

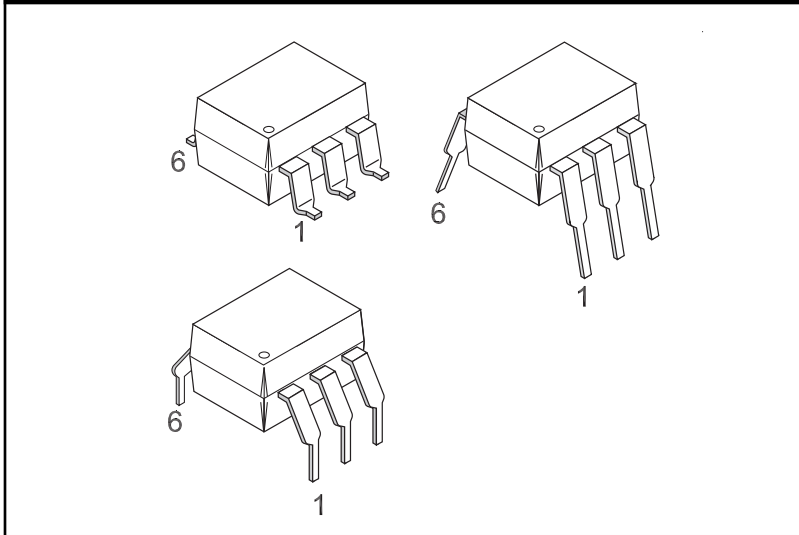
H11AA1-M

H11AA2-M

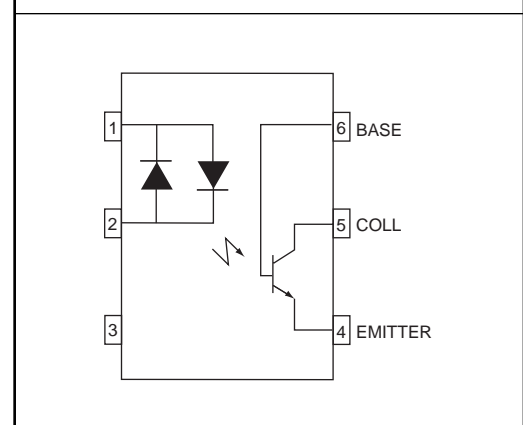
H11AA3-M

H11AA4-M

**PACKAGE**



**SCHEMATIC**



**DESCRIPTION**

The H11AAX-M series consists of two gallium-arsenide infrared emitting diodes connected in inverse parallel driving a single silicon phototransistor output.

**FEATURES**

- Bi-polar emitter input
- Built-in reverse polarity input protection
- Underwriters Laboratory (UL) recognized File #E90700, Volume 2
- VDE approved File #102497 (ordering option 'V')

**APPLICATIONS**

- AC line monitor
- Unknown polarity DC sensor
- Telephone line interface

**H11AA1-M**

**H11AA2-M**

**H11AA3-M**

**H11AA4-M**

**ABSOLUTE MAXIMUM RATINGS** ( $T_A = 25^\circ\text{C}$  Unless otherwise specified)

Parameter	Symbol	Device	Value	Units
<b>TOTAL DEVICE</b>				
Storage Temperature	$T_{STG}$	All	-40 to +150	$^\circ\text{C}$
Operating Temperature	$T_{OPR}$	All	-40 to +100	$^\circ\text{C}$
Lead Solder Temperature	$T_{SOL}$	All	260 for 10 sec	$^\circ\text{C}$
Total Device Power Dissipation Derate Linearly From $25^\circ\text{C}$	$P_D$	All	250	mW
			2.94	mW/ $^\circ\text{C}$
<b>EMITTER</b>				
Continuous Forward Current	$I_F$	All	60	mA
Forward Current – Peak (1 $\mu\text{s}$ pulse, 300 pps)	$I_F(\text{pk})$	All	$\pm 1.0$	A
LED Power Dissipation Derate Linearly From $25^\circ\text{C}$	$P_D$	All	120	mW
			1.41	mW/ $^\circ\text{C}$
<b>DETECTOR</b>				
Continuous Collector Current	$I_C$	All	50	mA
Detector Power Dissipation Derate linearity from $25^\circ\text{C}$	$P_D$	All	150	mW
			1.76	mW/ $^\circ\text{C}$

**ELECTRICAL CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  Unless otherwise specified.)

**INDIVIDUAL COMPONENT CHARACTERISTICS**

Parameter	Test Conditions	Symbol	Device	Min	Typ*	Max	Unit	
<b>EMITTER</b>								
Input Forward Voltage	$I_F = \pm 10 \text{ mA}$	$V_F$	All		1.17	1.5	V	
Capacitance	$V_F = 0 \text{ V}, f = 1.0 \text{ MHz}$	$C_J$	All		80		pF	
<b>DETECTOR</b>								
Breakdown Voltage Collector to Emitter	$I_C = 1.0 \text{ mA}, I_F = 0$	$BV_{CEO}$	All	30	100		V	
Collector to Base	$I_C = 100 \mu\text{A}, I_F = 0$	$BV_{CBO}$	All	70	120		V	
Emitter to Base	$I_E = 100 \mu\text{A}, I_F = 0$	$BV_{EBO}$	All	5	10		V	
Emitter to Collector	$I_E = 100 \mu\text{A}, I_F = 0$	$BV_{ECO}$	All	7	10		V	
Leakage Current Collector to Emitter	$V_{CE} = 10 \text{ V}, I_F = 0$	$I_{CEO}$	H11AA1,3,4(-M)		1	50	nA	
			H11AA2-M		1	200		
Capacitance	$V_{CE} = 0, f = 1 \text{ MHz}$	$C_{CE}$	All		10		pF	
				$C_{CB}$		80		pF
					$C_{EB}$		15	

\*Typical values at  $T_A = 25^\circ\text{C}$

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**TRANSFER CHARACTERISTICS** ( $T_A = 25^\circ\text{C}$  Unless otherwise specified.)

Characteristics	Test Conditions	Symbol	Device	Min	Typ*	Max	Units
Current Transfer Ratio, Collector to Emitter	$I_F = \pm 10 \text{ mA}, V_{CE} = 10 \text{ V}$	$CTR_{CE}$	H11AA4-M	100			%
			H11AA3-M	50			
			H11AA1-M	20			
			H11AA2-M	10			
Current Transfer Ratio, Symmetry	$I_F = \pm 10 \text{ mA}, V_{CE} = 10 \text{ V}$ (Figure 11)		All	.33		3.0	
Saturation Voltage Collector to Emitter	$I_F = \pm 10 \text{ mA}, I_{CE} = 0.5 \text{ mA}$	$V_{CE(SAT)}$	All			.40	V

**ISOLATION CHARACTERISTICS**

Characteristic	Test Conditions	Symbol	Min	Typ*	Max	Units
Package Capacitance input/output	$V_{I-O} = 0, f = 1 \text{ MHz}$	$C_{I-O}$		0.7		pF
Isolation Voltage	$f = 60 \text{ Hz}, t = 1 \text{ sec.}$	$V_{ISO}$	7500			Vac(pk)
Isolation Resistance	$V_{I-O} = 500 \text{ VDC}$	$R_{ISO}$	$10^{11}$			$\Omega$

\*Typical values at  $T_A = 25^\circ\text{C}$

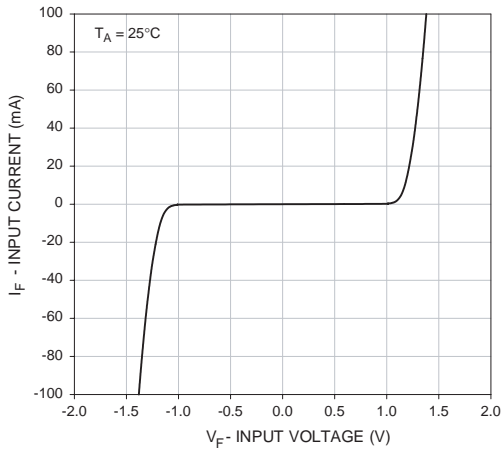
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**H11AA2-M**

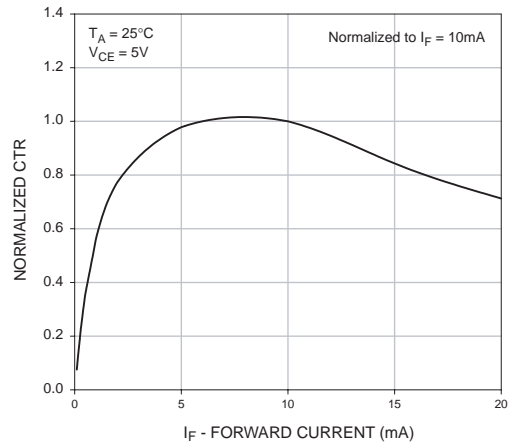
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**H11AA4-M**

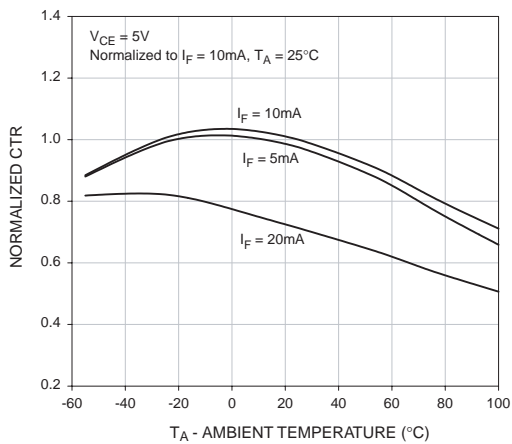
**Fig. 1 Input Voltage vs. Input Current**



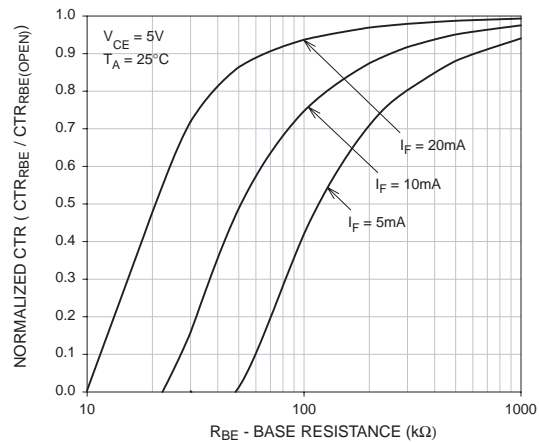
**Fig. 2 Normalized CTR vs. Forward Current**



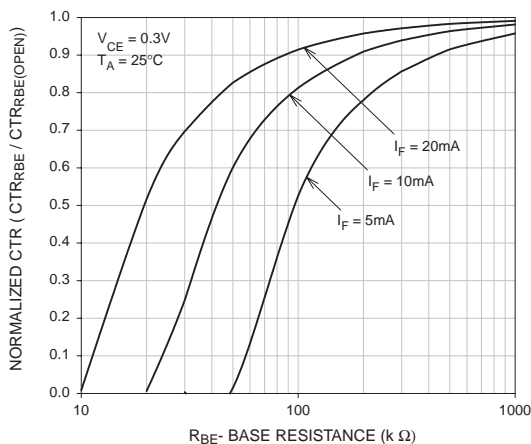
**Fig. 3 Normalized CTR vs. Ambient Temperature**



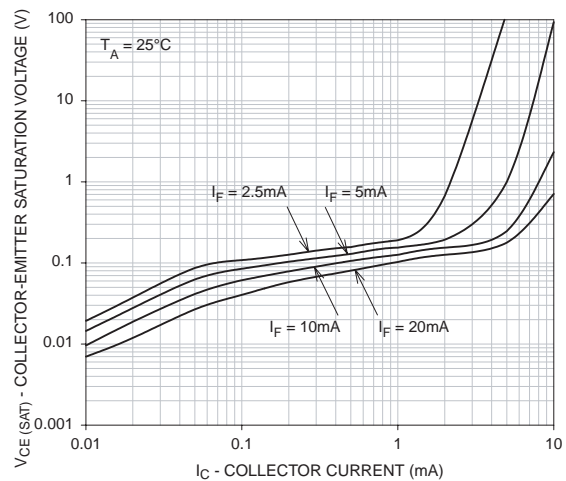
**Fig. 4 CTR vs. RBE (Unsaturated)**



**Fig. 5 CTR vs. RBE (Saturated)**



**Fig. 6 Collector-Emitter Saturation Voltage vs. Collector Current**



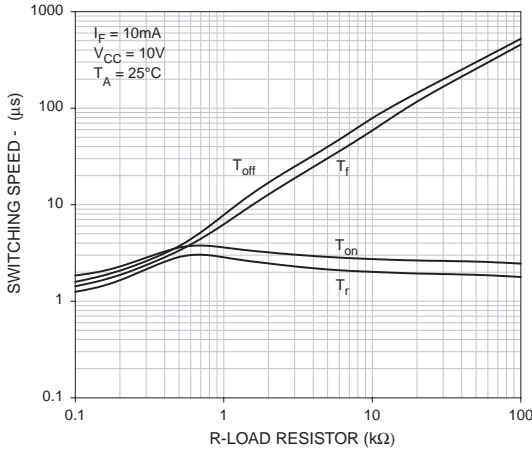
**H11AA1-M**

**H11AA2-M**

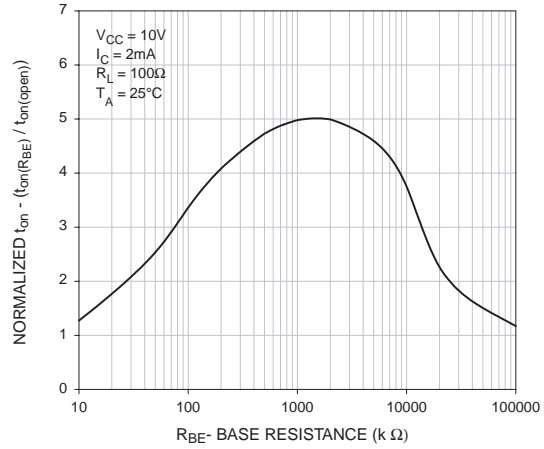
**H11AA3-M**

**H11AA4-M**

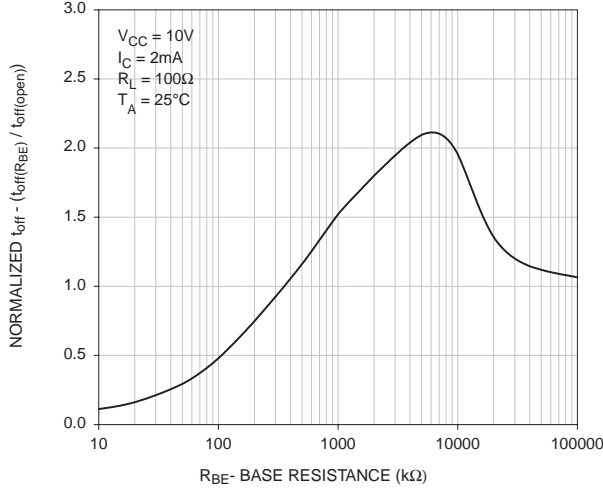
**Fig. 7 Switching Speed vs. Load Resistor**



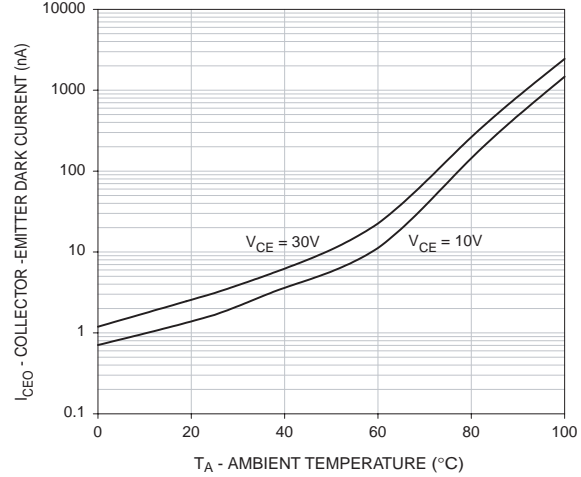
**Fig. 8 Normalized  $t_{on}$  vs.  $R_{BE}$**



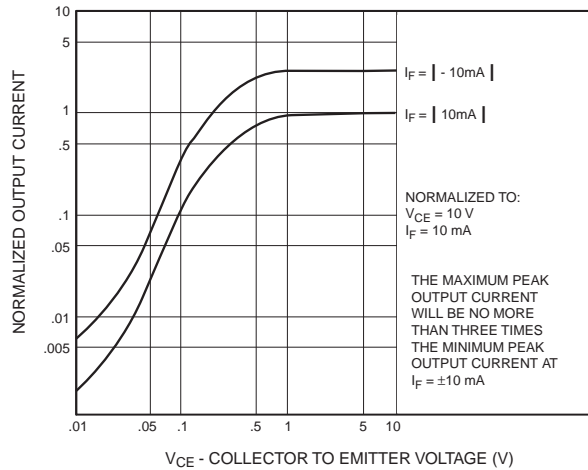
**Fig. 9 Normalized  $t_{off}$  vs.  $R_{BE}$**



**Fig. 10 Dark Current vs. Ambient Temperature**



**Fig. 11 Output Symmetry Characteristics**



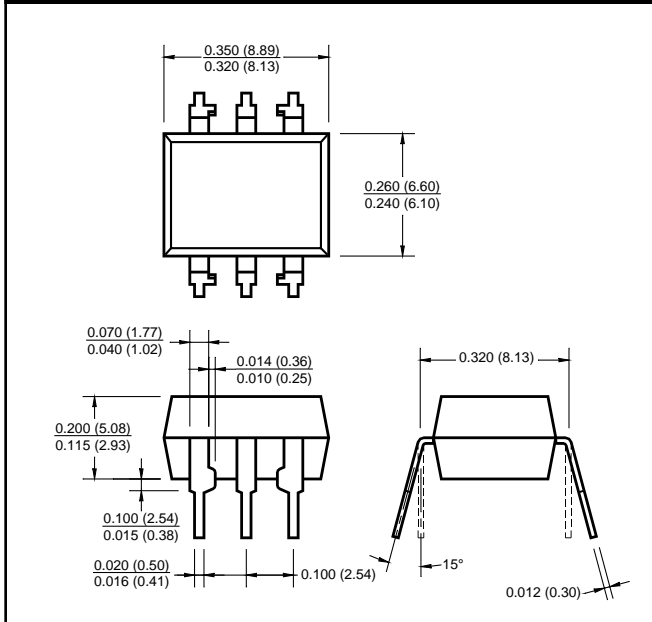
**H11AA1-M**

**H11AA2-M**

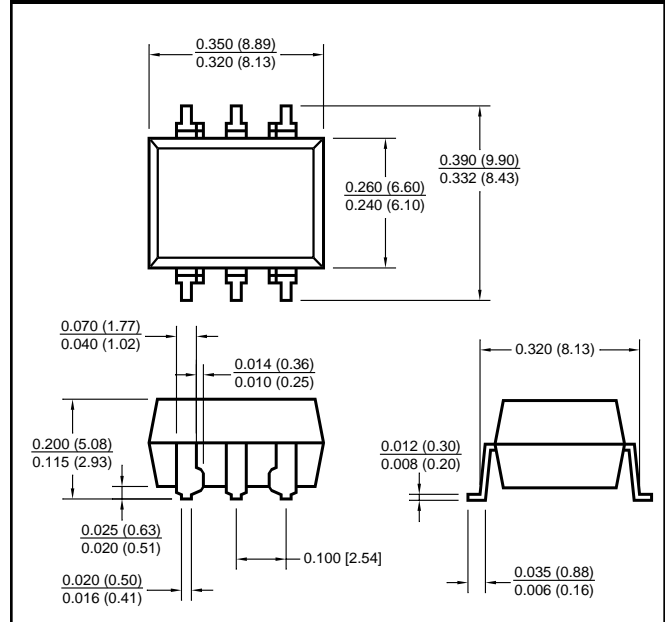
**H11AA3-M**

**H11AA4-M**

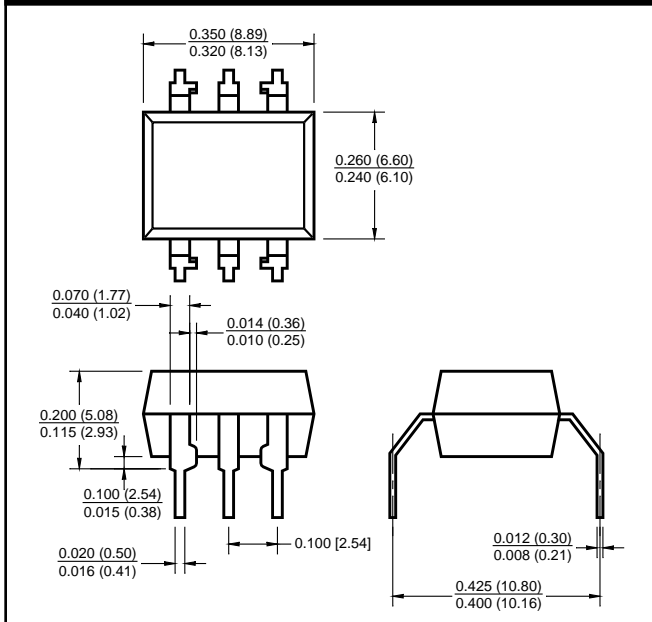
**Package Dimensions (Through Hole)**



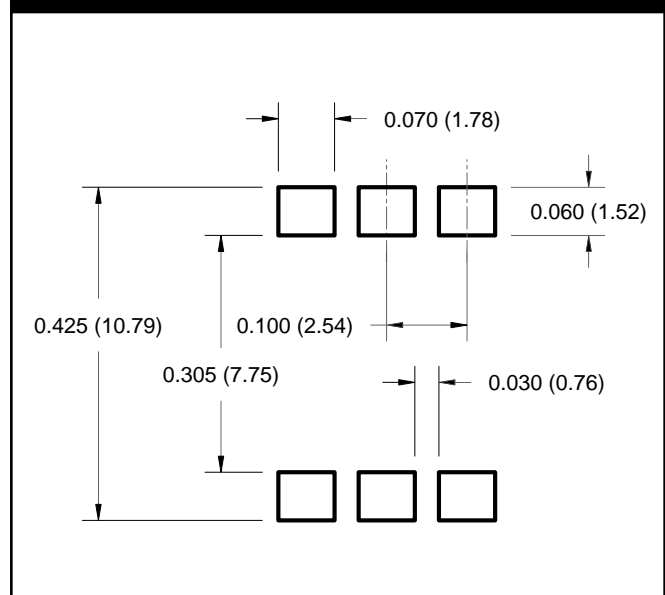
**Package Dimensions (Surface Mount)**



**Package Dimensions (0.4" Lead Spacing)**



**Recommended Pad Layout for  
Surface Mount Leadform**



**NOTE**

All dimensions are in inches (millimeters)

H11AA1-M

H11AA2-M

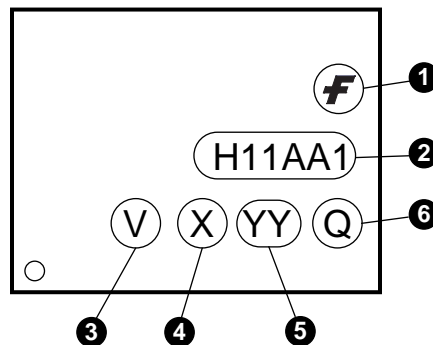
H11AA3-M

H11AA4-M

**ORDERING INFORMATION**

Option/Order Entry Identifier	Description
S	Surface Mount Lead Bend
SR2	Surface Mount; Tape and Reel
T	0.4" Lead Spacing
V	VDE 0884
TV	VDE 0884, 0.4" Lead Spacing
SV	VDE 0884, Surface Mount
SR2V	VDE 0884, Surface Mount, Tape & Reel

**MARKING INFORMATION**



Definitions	
1	Fairchild logo
2	Device number
3	VDE mark (Note: Only appears on parts ordered with VDE option – See order entry table)
4	One digit year code, e.g., '3'
5	Two digit work week ranging from '01' to '53'
6	Assembly package code

\*Note – Parts that do not have the 'V' option (see definition 3 above) that are marked with date code '325' or earlier are marked in portrait format.

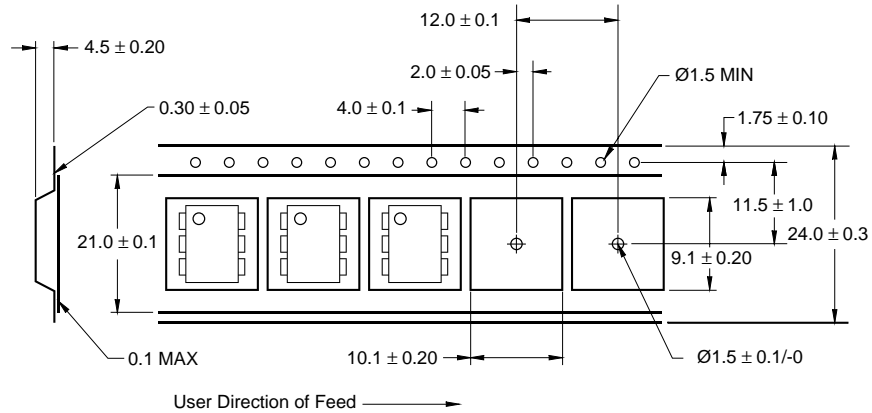
H11AA1-M

H11AA2-M

H11AA3-M

H11AA4-M

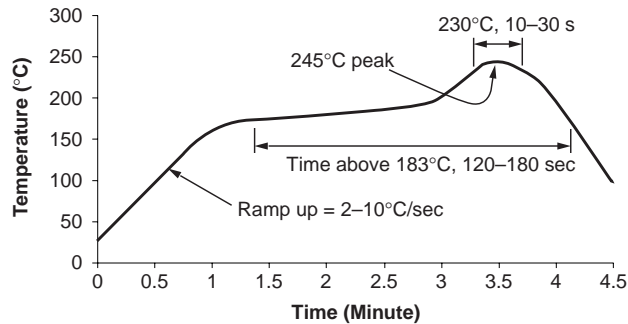
**Carrier Tape Specifications**



**NOTE**

All dimensions are in inches (millimeters)

**Reflow Profile (White Package, -M Suffix)**



- Peak reflow temperature:  $245^\circ\text{C}$  (package surface temperature)
- Time of temperature higher than  $183^\circ\text{C}$  for  $120-180 \text{ seconds}$
- One time soldering reflow is recommended



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**H11AA1-M**

**H11AA2-M**

**H11AA3-M**

**H11AA4-M**

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2. A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.